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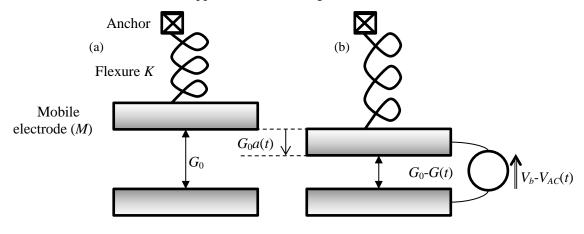
Reduced-order modeling of electrostatic MEMS resonators

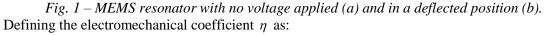
General equation of motion of a resonator

We consider the electrostatic actuation of a MEMS resonator with stiffness K, mass M, natural pulsation $\omega_0 = \sqrt{K/M}$ and quality factor Q.

An electrode with surface area S_e is situated across a gap G_0 from the resonator, supposed to be very small with respect to the lateral dimensions of the electrode. A voltage $V(t) = V_b - V_{AC}(t)$ is applied across the gap. It exerts an electrostatic force on the resonator and sets it into motion. Throughout the paper, the actuation voltage is assumed to be very small with respect to the bias voltage, i.e. $V_{AC} \ll V_b$.

The position of the resonator as it moves across the gap is given by $G(t) = G_0 a(t)$, so that a = 1 means that the structure touches the opposite electrode (Fig. 1).





$$\eta = \frac{\varepsilon_0 S_e}{2MG_0^3}, \qquad (1)$$

where ε_0 is the permittivity of vacuum, the dynamics of the resonator are governed by:

$$\frac{d^2a}{dt^2} + \frac{\omega_0}{Q}\frac{da}{dt} + \omega_0^2 a \left(1 + \gamma a^2\right) = \eta \left(V_b - V_{AC}\right)^2 N(a)$$
(2)

where γ is the Duffing coefficient of the elastic spring, and N(a) represents the dependence of the electrostatic force with respect to *a*. This function depends on the resonator geometry (parallel-plate, CC-beam, cantilever) and also on the effective area of the electrode (the electrode might be smaller than the resonator).

In the case of a 2-port resonator, where one electrode is used for actuation and another at potential V_{det} is used for detection (Fig. 2), the dynamics of the resonator are governed by:

Fig. 2 – *Double-sided configuration. The lower electrode is used for actuation, the upper one for detection.*

With these notations, the input capacitance (capacitance between the actuation electrode and the mobile electrode) is equal to:

$$C_{in} = \frac{\varepsilon_0 S_e}{G_0} \Gamma(a) \triangleq C_0 \Gamma(a) \qquad (4)$$

and the output capacitance is equal to:

$$C_{out} = C_0 \Gamma(-a) \tag{5}$$

where $\Gamma(a)$ is a geometry-dependent function.

Typical expressions of γ , $\Gamma(a)$, N(a), K and M are given hereafter for various geometries.

Parallel-plate resonator

This case is typically met when a large seismic mass is supported by small flexures. In that case, one may derive K and γ from a static analysis of the flexures, while M is just the mass of the rigid part. We also have:

$$N(a) = \frac{1}{(1-a)^2}$$
 (6)

$$\Gamma(a) = \frac{1}{1-a}.$$
 (7)

Clamped-clamped beam

A clamped-clamped beam (or CC-beam) is a beam fixed at both ends (Fig. 3). In that case, a(t) represents the motion of the midpoint of the beam. The beam has the following properties: Young's modulus E, density ρ , length L, thickness (in direction of motion) h and width b.

The beam is supposed to be initially straight and unconstrained. The in/out electrodes have the same length as the beam ($S_e = bL$) and the aspect ratio of the device guarantees that the parallel-plate approximation holds in a cross-section of the beam.

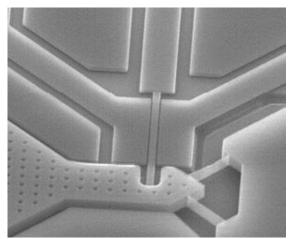


Fig. 3 – Sensing element of the M&NEMS project: a CC-beam between two electrodes.

In that case, we have:

$$K = 16.56 \frac{Ebh^3}{L^3}, \ M = 0.397 \rho bhL, \ \gamma = 0.719 \frac{G_0^2}{h^2}, \qquad (8)$$
$$N(a) = 0.523 \frac{1+0.017a}{(1-a)^{3/2}}, \qquad (9)$$
$$\Gamma(a) = \frac{1+0.029a}{(1-a)^{1/2}}. \qquad (10)$$

Cantilever beam

A cantilever beam is a beam fixed at one end and free to move at the other end. In that case, a(t) represents the motion of the free extremity of the beam. The beam has the following properties: Young's modulus E, density ρ , length L, thickness (in direction of motion) h and width b. The beam is supposed to be initially straight and unconstrained. The in/out electrodes have the same length as the beam ($S_e = bL$) and the aspect ratio of the device guarantees that the parallel-plate approximation holds in a cross-section of the beam.

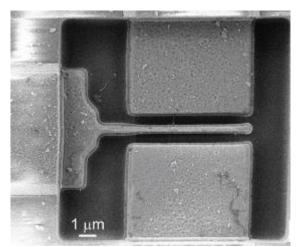


Fig. 4 – Cantilever beam fabricated with AMS035 process at UAB.

In that case, we have:

$$K = 0.257 \frac{Ebh^{3}}{L^{3}}, M = 0.25\rho bhL, \gamma = 0, \qquad (11)$$
$$N(a) = 0.392 \left(\frac{1+0.783a}{1-a} + (0.531+0.114a)\log(1-a)\right), \qquad (12)$$
$$\Gamma(a) = 1 - 0.505a - (0.888 - 0.201a)\log(1-a). \qquad (13)$$

Other geometries

In the case of beam resonators, the reduced order models of the modal force N(a) are obtained as in [1], by minimizing the relative error between a numerical estimation of the projection of the electrostatic force on the first beam eigenmode, denoted by w_i :

$$N(a) = \int_{\alpha}^{\beta} \frac{w_1(x)}{(1 - aw_1(x))^2} dx \qquad (14)$$

and a model parameterized by θ , $\hat{N}(a, \theta)$. The relative error is summed over a set of chosen modal amplitudes a_i , so that the optimal parameters are given by:

$$\boldsymbol{\theta}_{opt} = \arg\min\sum_{i} \left(1 - \frac{\hat{N}(a_i, \boldsymbol{\theta})}{N(a_i)} \right)^2.$$
(15)

For a clamped-clamped beam, provided $\beta = 1 - \alpha$ (the actuation electrode is centered), the model has the following form:

$$\hat{N}(a,\theta) = \frac{N_{CC}}{(1-a)^{3/2}} (1+\theta a).$$
 (16)

For a cantilever beam, provided $\beta = 1$ (the actuation electrode extends to the tip of the beam), it can be chosen as:

$$\hat{N}(a,\theta_1,\theta_2,\theta_3) = N_{CA}\left(\frac{1+\theta_1a}{1-a} + (\theta_2+\theta_3a)\log(1-a)\right).$$
(17)

The coefficients N_{cc} and N_{CA} are calculated so that $\hat{N}(0, \theta) = N(0)$, i.e. the model and the projection of the electrostatic force coincide when a = 0. The structure of the model, independently of its parameters, guarantees that the asymptotic behavior (as *a* goes to 1) of $\hat{N}(a, \theta)$ is the same as that of N(a), as shown in [1], so that the relative error is bounded across the whole gap.

To obtain the parameters appearing in (9) and (12), (15) is solved: this is a trivial linear least squares problem. The error is minimized over a set of 100 values a_i of the modal amplitude, uniformly spaced between -0.99 and 0.99.

Introducing the log function in the ROM of the cantilever beam (17) gives better results than the approach proposed in [1]. This approach was already used in [2].

The same approach can be used to approximate integrals of the form:

$$N(a,n,p) = \int_{\alpha}^{\beta} \frac{w_1^{p}}{(1-aw_1(x))^n} dx, \qquad (18)$$

and thus account for fringing field effects (n = p = 1), other nonlinear forces (e.g. squeezed-film damping, Van der Waals, etc.). It is also used to compute the approximations used for the capacitance (10) (13), which corresponds to the case n = 0, p = 1.

Note that, it is possible to compute N(a) with finite element software without having to use the parallel-plate assumption. This calculation is very expensive though. But the same reduced-order modeling approach as above can still be used to fit a model to the numerical estimation of N(a).

Electrical equivalent

To derive an electrical equivalent of the system, (3) is linearized, the constant terms are dropped and the bias voltage is assumed large with respect to the other voltages, leading to:

$$\frac{d^{2}a}{dt^{2}} + \frac{\omega_{0}}{Q}\frac{da}{dt} + \left(\omega_{0}^{2} - KN'(0)\eta V_{b}^{2}\right)a \approx -2\eta V_{b}V_{AC}N(0), \quad (19)$$

where K = 1 in the single-sided configuration and K = 2 in the double-sided configuration, and the prime denotes differentiation with respect to *a*. From (5), the motional current is given by:

$$i_{mot} = -V_b C_0 \Gamma'(0) \dot{a} = -V_b C_0 N(0) \dot{a} .$$
 (20)

It is thus found that:

$$R_{m} = \frac{1}{C_{0}} \frac{\omega_{0}}{Q} \frac{1}{2\eta N(0)^{2} V_{b}^{2}}, \quad (21)$$

$$C_{m} = C_{0} \frac{2\eta N(0)^{2} V_{b}^{2}}{\omega_{0}^{2} - KN'(0) \eta V_{b}^{2}}, \quad (22)$$

$$L_{m} = \frac{1}{C_{0}} \frac{1}{2\eta N(0)^{2} V_{b}^{2}}. \quad (23)$$

The value of N'(0) is 2 for parallel-plate resonators, 0.794 for CC-beams and 0.5 for cantilever beams.

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[2] J. Juillard, "Analysis of resonant pull-in of micro-electromechanical oscillators," Journal of Sound and Vibration, vol. 350, pp. 123-139, 2015.